

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Atty. Docket: 82821

ECHROLOGY CENTER 1700

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re U.S. Patent Application

Applicant: Nakamura et al.

Serial No.: 09/856,212

Filed: May 18, 2002

For: PRODUCTION METHOD FOR SILICON
SINGLE CRYSTAL WAFER

POWER TO INSPECT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313

Dear Sirs:

Please permit any one of the following individuals to inspect the above-identified U.S. Patent Application, to make copies of any papers that they may desire and to inspect and make copies of any and all assignments recorded with respect to the above-identified U.S. Patent Application.

J. Stuart Talbart Fred Taylor Denise M. Augustine Peter A. Borsari Shannon T. Dunn

Respectfully submitted,

Gerald T. Shekleton Registration No. 27,466

Dated: August 5, 2003